Se	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/650,481	WONG ET AL.	
Examiner	Art Unit	
Annan Q. Shang	2623	

SEARCHED			
Class	Subclass	Date	Examiner
725	58,106- 110,134, 142	6/20/2007	A.S
386	83	6/20/2007	A.S
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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